SUPPORTING INFORMATION

Understanding the Power of Luminescence Ratiometric Thermal History Indicators driven by Phase Transitions: The case of Eu³⁺ doped LaVO₄

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-c) as a function of time.

Figure S2. The XRD patterns of LaVO₄:1%Eu³⁺ annealed at different temperatures.



Figure S3. The TEM images of the LaVO₄:Eu³⁺ annealed at 400°C-a-d; and at 800°C e-h).



Figure S4. The comparison of excitation spectra upon monitoring the emission at 618 nm – a) and emission spectra upon excitation at 266 nm – b) as a function of annealing temperature for tetrahedral and monoclinic LaVO₄:1%Eu³⁺ nanocrystals; magnified view of particular emission bands of Eu³⁺ ions: ${}^{5}D_{0} \rightarrow {}^{5}F_{1} - c$), ${}^{5}D_{0} \rightarrow {}^{5}F_{2} - d$) and ${}^{5}D_{0} \rightarrow {}^{5}F_{4} - e$) obtained at RT.



Figure S5. The comparison of excitation spectra upon monitoring the emission at 618 nm – a, c, e) and emission spectra upon excitation at 266 nm – b, d, f) as a function of annealing time for Eu^{3+} -doped LaVO₄ nanocrystals annealed at 400°C, 600°C and 900°C obtained at RT.



Figure S6. Luminescence decay curve from ⁵D₀ state of Eu³⁺ ions in LaVO₄:Eu³⁺ annealed at 400°C-a), 600°C-b) and 900°C-c) for different time.

The LIR vs annealing temperature dependence presented in Figure 3c can be fitted using the following polynomial function:

$$LIR = 14.83 - 0.062T + 2.51 \cdot 10^{-4}T^{2} - 3.61 \cdot 10^{-7}T^{3} + 1.62 \cdot 10^{-10}T^{4}$$
(S1)



Figure S7. The photographs of the series of LaVO₄:1% Eu³⁺ nanocrystals AP and annealed at 200°C, 400°C, 600°C, 700°C, 800°C, 900°C, 1000°C taken with the use of 590 nm – a) and 620 nm – b) bandpass filters, the map of LIR distribution – c).



Figure S8. The XRD patter of LaVO₄:1% Eu³⁺ annealed at 600°C for 5 minutes.